issue Classification	
	I

Application/Control No.	Applicant(s)/Patent under Reexamination
10/692,266	PIEHL, ARTHUR_R.
Examiner	Art Unit

2851

	ICCUE CLASSIFICATION													
ISSUE CLASSIFICATION ORIGINAL CROSS REFERENCE(S)														
ORIGINAL CROSS REFERENCE(S) CLASS SUBCLASS CLASS SUBCLASS (ONE SUBCLASS PER BLOCK)														
359 443	353	122												
	333	122												
G A 2 B 21/66														
0 3 B 21/30														
21/00														
1														
1														
		1 21												
(A§sistant Examiner) (Date	·	has							Total Claims Allowed: 23					
		C	hristo	pher	Maho	ney			O:G. O.G.					
1 / Januar 8/81	<i>U</i> 4						. اربه			Claim(s)		t Fig.	
(Lega Instruments Examiner)	Date)	(Prir	nary Exa	miner)		(Date)	8/1/6	Я		1		,	0	
										•				
Claims renumbered in the	same orde	r as presen	ted by	appli	icant	ОС	PA		□ T.	D.		□R	.1.47	
_ _ _		<u>a</u>		a			a			a				
Final Original Final Original	Final	Original	Final	Original		Final	Original		Final	Original		Final	Original	
" 5 " " 5	<u> </u>	ō	ഥ	ō		,LL	ō		ட	Ö		ட	ō	
1 31		61		91			121			151			181	
2 32		62		92			122			152			182	
3 33		63		93			123			153			183	
4 34		64		94			124			154			184	
5 35 6 36	\longrightarrow	65 66		95 96	ł	·	125 126			155 156			185 186	
7 37		67		97			127			157			187	
8 38		68		98			128			158			188	
9 39		69		99			129			159			189	
10 40		70		100			130			160			190	
11 41 42		71 72		101 102			131 132			161			191	
13 43	₩ 	73		102			133			162 163			192 193	
14 44		74		104			134			164	ŀ		194	
15 45		75		105			135			165			195	
16 46		76		106			136			166			196	
17 47		77		107			137		•	167			197	
18 48 19 49	₩ 	78 79		108 109			138 139		-	168 169			198 199	
20 50	<u> </u>	80		110			140			170			200	
21 51		81		111			141			171	l		201	
22 52		82		112			142			172			202	
23 53		83		113			143			173			203	
24 54 55		84 85		114 115			144 145			174			204	
26 56	<u> </u>	86		116			146			175 176			205 206	
27 57		87		117			147			177	ŀ		207	
28 58		88		118			148			178	l		208	
29 59		89		119			149			179			209	
30 60		90		120			150]	180			210	

Christopher E. Mahoney